

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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		W. Patty Chen	2871	

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*	B	US-5,019,001	05-1991	Abe et al.	445/3
*	C	US-6,211,534	04-2001	Matsumoto, Seiichi	257/59
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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